Discrete IGBTs Silicon N-Channel IGBT

# GT30J110SRA

#### 1. Applications

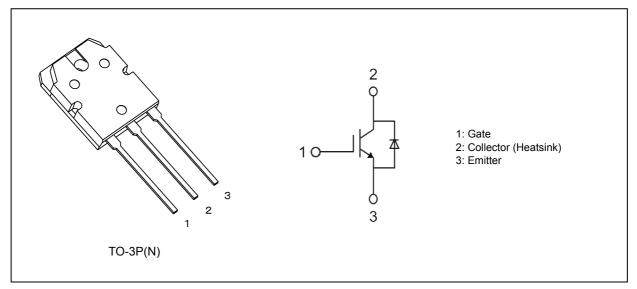
- Dedicated to Voltage-Resonant Inverter Switching Applications
- Dedicated to Soft Switching Applications
- Dedicated to Induction Cooktops and Home Appliance Applications

Note: The product(s) described herein should not be used for any other application.

#### 2. Features

- (1) 6.5th generation
- (2) The RC-IGBT consists of a freewheeling diode (FWD) monolithically integrated in an IGBT chip.
- (3) Enhancement mode
- (4) High-speed switching:
  - IGBT  $~t_f$  = 0.17  $\mu s$  (typ.) (I\_C = 60 A)
- (5) Low saturation voltage:  $V_{CE(sat)} = 1.60$  V (typ.) (I<sub>C</sub> = 30 A, T<sub>a</sub> = 25 °C)
- (6) High junction temperature:  $T_j = 175 \text{ °C} (max)$

#### 3. Packaging and Internal Circuit



#### 4. Absolute Maximum Ratings (Note) ( $T_a = 25 \degree$ C, unless otherwise specified)

Characteristics			Symbol	Rating	Unit
Collector-emitter voltage			V <sub>CES</sub>	1100	V
Gate-emitter voltage			V <sub>GES</sub>	±25	V
Collector current (DC)	(T <sub>c</sub> = 25 °C)		Ι <sub>C</sub>	60	A
Collector current (DC)	(T <sub>c</sub> = 100 °C)			30	1
Collector current (1 ms)			I <sub>CP</sub>	120	A
Non-repetitive peak collector current		(Note 1)	I <sub>CSM</sub>	250	A
Diode forward current (DC)	(T <sub>c</sub> = 25 °C)		lF	60	A
Diode forward current (DC)	(T <sub>c</sub> = 100 °C)			30	1
Diode forward current (100 μs)			I <sub>FP</sub>	120	A
Collector power dissipation	(T <sub>c</sub> = 25 °C)		Pc	312	W
Junction temperature			Tj	175	°C
Storage temperature			T <sub>stg</sub>	-55 to 175	°C
Mounting torque			TOR	0.8	N · m

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

In general, loss of IGBT increases more when it has positive temperature coefficient and gets higher temperature.

In case that the temperature rise due to loss of IGBT exceeds the heat release capacity of a device, it leads to thermorunaway and results in destruction.

Therefore, please design heat release of a device with due consideration to the temperature rise of IGBT.

Note 1: The maximum value of the capacitor charging current limited on T<sub>j</sub> < 175 °C and t < 4  $\mu s$ 

#### 5. Thermal Characteristics

Characteristics	Symbol	Мах	Unit
Junction-to-case thermal resistance		0.48	°C/W

#### 6. Electrical Characteristics

## 6.1. Static Characteristics ( $T_a = 25$ °C, unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I <sub>GES</sub>	$V_{GE}$ = ±25 V, $V_{CE}$ = 0 V	_		±100	nA
Collector cut-off current	I <sub>CES</sub>	V <sub>CE</sub> = 1100 V, V <sub>GE</sub> = 0 V			100	μA
Gate-emitter cut-off voltage	V <sub>GE(OFF)</sub>	I <sub>C</sub> = 60 mA, V <sub>CE</sub> = 5 V	5.0	_	7.0	V
Collector-emitter saturation voltage	V <sub>CE(sat)(1)</sub>	$I_{C}$ = 30 A, $V_{GE}$ = 15 V (pulse test)	—	1.60	1.80	V
	V <sub>CE(sat)(2)</sub>	$I_C = 30 \text{ A}, V_{GE} = 15 \text{ V},$ $T_c = 125 \text{ °C} \text{ (pulse test)}$	_	1.80	_	
	V <sub>CE(sat)(3)</sub>	I <sub>C</sub> = 60 A, V <sub>GE</sub> = 15 V (pulse test)	_	2.15	—	
	V <sub>CE(sat)(4)</sub>	$I_{C} = 60 \text{ A}, V_{GE} = 15 \text{ V},$ $T_{c} = 125 \text{ °C} \text{ (pulse test)}$	—	2.50	—	
Diode forward voltage	V <sub>F(1)</sub>	I <sub>F</sub> = 30 A, V <sub>GE</sub> = 0 V (pulse test)	—	1.40	1.80	V
	V <sub>F(2)</sub>	$I_F$ = 30 A, $V_{GE}$ = 0 V, T <sub>c</sub> = 125 °C (pulse test)	—	1.35	—	

### 6.2. Dynamic Characteristics ( $T_a = 25$ °C, unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>ies</sub>	V <sub>CE</sub> = 25 V, V <sub>GE</sub> = 0 V,	_	2700	—	pF
Reverse transfer capacitance	C <sub>res</sub>	f = 100 kHz	_	32	—	
Output capacitance	C <sub>oes</sub>		_	42	_	
Total gate charge	Qg	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 60 A, V <sub>GE</sub> = 15 V	_	155	_	nC
Switching time (rise time)	tr	Resistive load $V_{CE}$ = 600 V, I <sub>C</sub> = 60 A, $V_{GE}$ = +15 V, R <sub>G</sub> = 10 $\Omega$	_	0.14	—	μS
Switching time (turn-on time)	t <sub>on</sub>		_	0.20	—	
Switching time (fall time)	t <sub>f</sub>	See Fig. 6.2.1, 6.2.2	_	0.17	0.40	
Switching time (turn-off time)	t <sub>off</sub>		_	0.33	—	
Switching loss (turn-off switching loss)	E <sub>off(1)</sub>	Inductive load $V_{CE}$ = 150 V, I <sub>C</sub> = 60 A, $V_{GE}$ = +15 V, R <sub>G</sub> = 39 $\Omega$ L = 30 $\mu$ H, C = 0.33 $\mu$ F See Fig. 6.2.3, 6.2.4		0.33		mJ
	E <sub>off(2)</sub>	Inductive load $V_{CE} = 150 \text{ V}, \text{ I}_{C} = 60 \text{ A},$ $V_{GE} = +15 \text{ V}, \text{ R}_{G} = 39 \Omega,$ $L = 30 \mu\text{H}, \text{ C} = 0.33 \mu\text{F}$ $T_{c} = 125 ^{\circ}\text{C}$ See Fig. 6.2.3, 6.2.4		0.55		

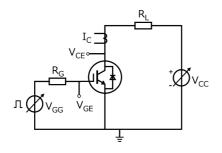


Fig. 6.2.1 Test Circuit of Switching Time

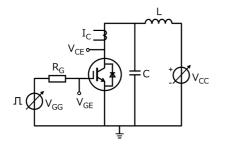


Fig. 6.2.3 Test Circuit of Switching Loss

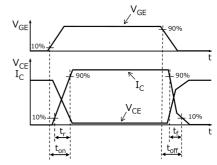


Fig. 6.2.2 Timing Chart of Switching Time

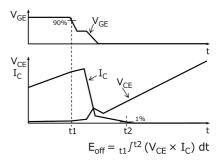


Fig. 6.2.4 Timing Chart of Switching Loss

### 7. Marking (Note)

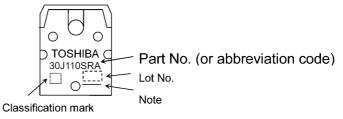
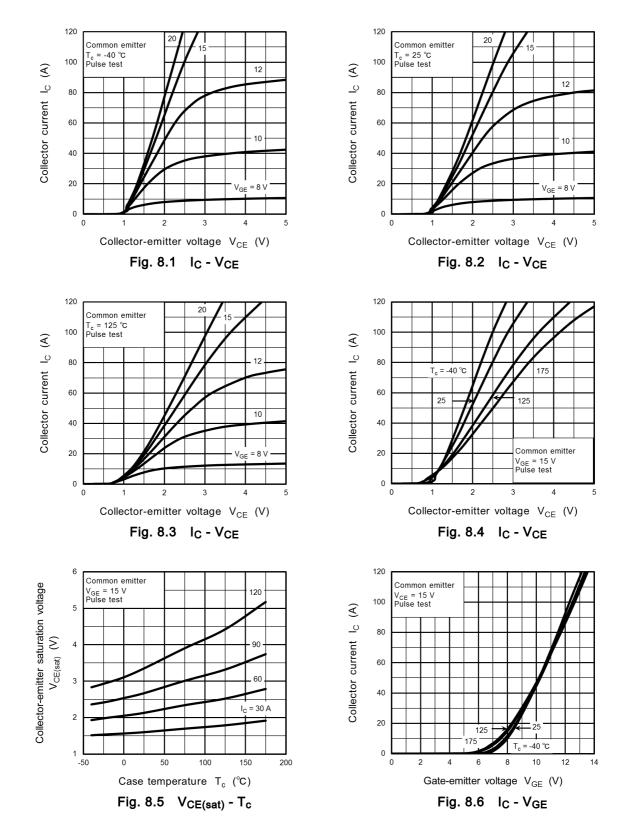


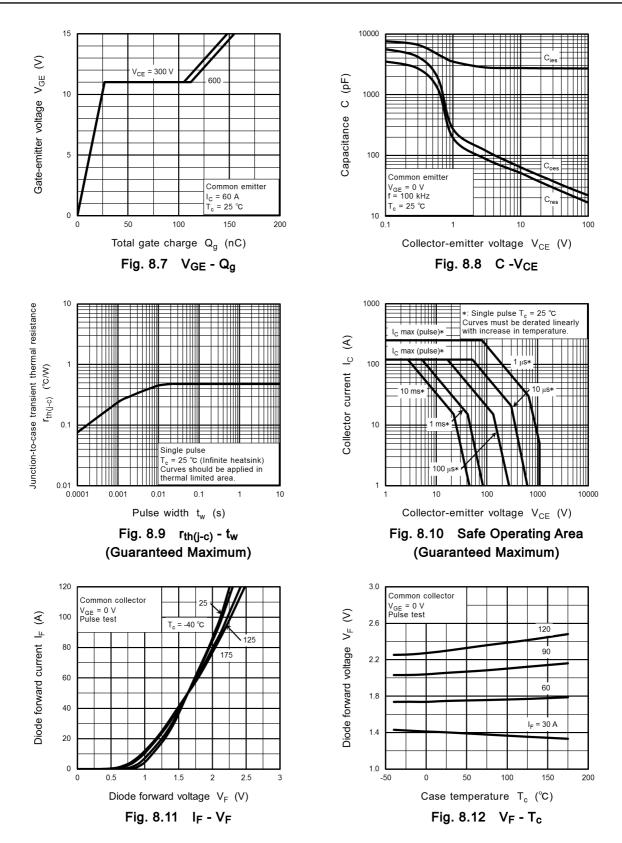
Fig. 7.1 Marking

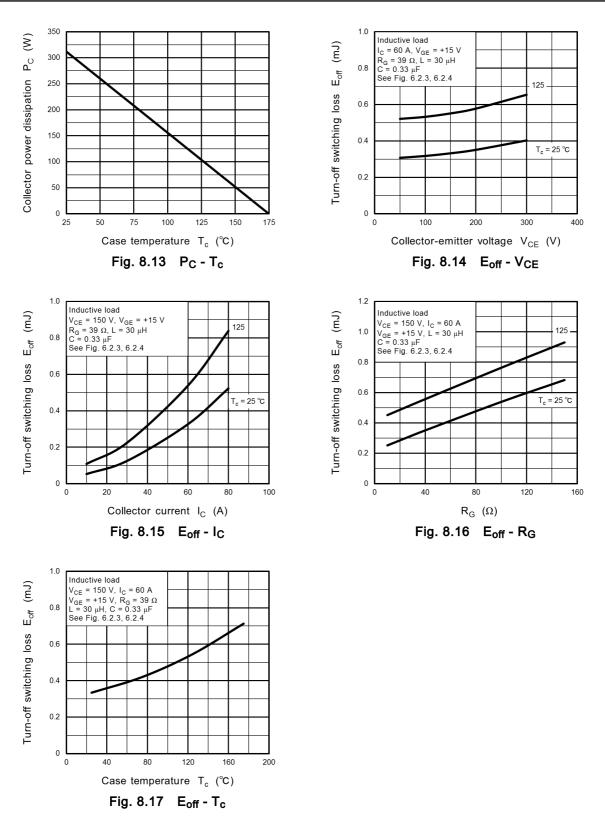
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Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

#### 8. Characteristics Curves (Note)





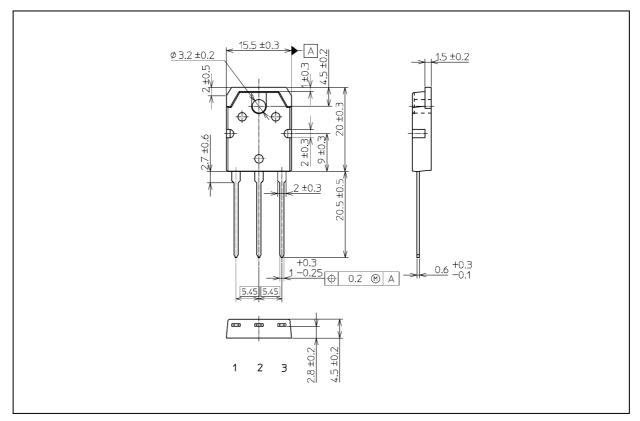


Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

## GT30J110SRA

#### Package Dimensions

Unit: mm



#### Weight: 4.6 g (typ.)

Package Name(s)	
TOSHIBA: 2-16C1S	
Nickname: TO-3P(N)	

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